

Date:- 20 Nov, 2003

Data Sheet Issue:- 1

Fast Recovery Diode Types M0659LC400 to M0659LC450

(Old Type No.: SM30-45CXC364)

Absolute Maximum Ratings

	VOLTAGE RATINGS	MAXIMUM LIMITS	UNITS
V _{RRM}	Repetitive peak reverse voltage, (note 1)	4500	V
V _{RSM}	Non-repetitive peak reverse voltage, (note 1)	4500	V

	OTHER RATINGS	MAXIMUM LIMITS	UNITS
I _{F(AV)M}	Maximum average forward current, T _{sink} =55°C, (note 2)	659	А
I _{F(AV)M}	Maximum average forward current. T _{sink} =100°C, (note 2)	312	А
I _{F(AV)M}	Maximum average forward. T _{sink} =100°C, (note 3)	178	А
I _{F(RMS)}	Nominal RMS forward current, T _{sink} =25°C, (note 2)	1315	А
I _{F(d.c.)}	D.C. forward current, T _{sink} =25°C, (note 4)	1108	А
I _{FSM}	Peak non-repetitive surge t_p =10ms, V_{RM} =60% V_{RRM} , (note 5)	7620	A
I _{FSM2}	Peak non-repetitive surge t_p =10ms, V_{RM} ≤10V, (note 5)	8470	А
l ² t	$I^{2}t$ capacity for fusing t _p =10ms, V _{RM} =60%V _{RRM} , (note 5)	290×10 ³	A ² s
l ² t	$I^{2}t$ capacity for fusing t _p =10ms, V _{RM} ≤10V, (note 5)	359×10 ³	A ² s
T _{j op}	Operating temperature range	-40 to +125	°C
T _{stg}	Storage temperature range	-40 to +150	°C

Notes:-

1) De-rating factor of 0.13% per °C is applicable for T_j below 25°C.

2) Double side cooled, single phase; 50Hz, 180° half-sinewave.

3) Single side cooled, single phase; 50Hz, 180° half-sinewave.

4) Double side cooled.

5) Half-sinewave, 125°C T_j initial.

Characteristics

	PARAMETER	MIN.	TYP.	MAX.	TEST CONDITIONS (Note 1)	UNITS	
V _{FM}	Maximum peak forward voltage	3.0 I _{FM} =1400A	I _{FM} =1400A	V			
	axinum pear lorward voltage	-	-	2.95	I _{FM} =1320A	v	
V _{T0}	Threshold voltage	-	-	1.71		V	
r⊤	Slope resistance	-	-	0.925		mΩ	
Marina	Maximum forward recovery veltage	-	-	110	di/dt = 1000A/µs, Tj=25°C	V	
VFRM	V _{FRM} Maximum forward recovery voltage	-	-	180	di/dt = 1000A/µs	v	
	RRM Peak reverse current	-	-	100	Rated V _{RRM}		
I _{RRM}		-	-	100	Rated V _{RRM} , Tj=25°C	mA	
Q _{rr}	Recovered charge	-	800	-		μC	
Q _{ra}	Recovered charge, 50% Chord	-	270	350	I _{FM} =1000A, t _p =1000μs, di/dt=60A/μs,	μC	
I _{rm}	Reverse recovery current	-	130	-	V _r =50V, 50% Chord.	А	
t _{rr}	Reverse recovery time, 50% Chord	-	4.2	-		μs	
R	Thermal registered, junction to bestaink	-	-	0.033	Double side cooled	K/W	
R _{thJK} 1	Thermal resistance, junction to heatsink	-	-	0.066	Single side cooled	r\/vv	
F	Mounting force	10	-	20		kN	
Wt	Weight	-	340	-		g	

Notes:-

Unless otherwise indicated T_j=125°C.
For other clamp forces consult factory.

Notes on Ratings and Characteristics

1.0 Voltage Grade Table

Voltage Grade	V _{RRM} (V)	V _{RSM} (V)	V _R dc (V)
40	4000	4100	2000
42	4200	4300	2040
44	4400	4500	2080
45	4500	4600	2100

2.0 De-rating Factor

A blocking voltage de-rating factor of 0.13% per °C is applicable to this device for T_i below 25°C.

3.0 ABCD Constants

These constants (applicable only over current range of V_F characteristic in Figure 1) are the coefficients of the expression for the forward characteristic given below:

$$V_F = A + B \cdot \ln(I_F) + C \cdot I_F + D \cdot \sqrt{I_F}$$

where I_F = instantaneous forward current.

4.0 Reverse recovery ratings

(i) Q_{ra} is based on 50% I_{rm} chord as shown in Fig.(a) below.



(ii) Q_{rr} is based on a 150µs integration time.

$$Q_{rr} = \int_{0}^{150\,\mu s} i_{rr}.dt$$

I.e.

(iii)
$$K \ Factor = \frac{t_1}{t_2}$$

5.0 Reverse Recovery Loss

The following procedure is recommended for use where it is necessary to include reverse recovery loss.

From waveforms of recovery current obtained from a high frequency shunt (see Note 1) and reverse voltage present during recovery, an instantaneous reverse recovery loss waveform must be constructed. Let the area under this waveform be E joules per pulse. A new sink temperature can then be evaluated from:

$$T_{SINK} = T_{J(MAX)} - E \cdot \left[k + f \cdot R_{th(JK)}\right]$$

Where k = 0.2314 (°C/W)/s

- E = Area under reverse loss waveform per pulse in joules (W.s.)
- f = Rated frequency in Hz at the original sink temperature.

 $R_{th(J-Hs)}$ = d.c. thermal resistance (°C/W)

The total dissipation is now given by:

$$W_{(tot)} = W_{(original)} + E \cdot f$$

NOTE 1 - Reverse Recovery Loss by Measurement

This device has a low reverse recovered charge and peak reverse recovery current. When measuring the charge, care must be taken to ensure that:

(a) AC coupled devices such as current transformers are not affected by prior passage of high amplitude forward current.

(b) A suitable, polarised, clipping circuit must be connected to the input of the measuring oscilloscope to avoid overloading the internal amplifiers by the relatively high amplitude forward current signal.

(c) Measurement of reverse recovery waveform should be carried out with an appropriate critically damped snubber, connected across diode anode to cathode. The formula used for the calculation of this snubber is shown below:

$$R^2 = 4 \cdot \frac{V_r}{C_s \cdot \frac{di}{dt}}$$

Where: V_r = Commutating source voltage

 C_{S} = Snubber capacitance

R = Snubber resistance

6.0 Snubber Components

When selecting snubber components, care must be taken not to use excessively large values of snubber capacitor or excessively small values of snubber resistor. Such excessive component values may lead to device damage due to the large resultant values of snubber discharge current. If required, please consult the factory for assistance.

7.0 Computer Modelling Parameters

7.1 Device Dissipation Calculations

$$I_{AV} = \frac{-V_o + \sqrt{V_o + 4 \cdot ff^2 \cdot r_s \cdot W_{AV}}}{2 \cdot ff^2 \cdot r_s}$$

Where $V_0 = 1.71$ V, $r_s = 0.925$ m Ω

ff = form factor (normally unity for fast diode applications)

$$W_{AV} = \frac{\Delta T}{R_{th}}$$
$$\Delta T = T_{j(MAX)} - T_K$$

7.2 Calculation of V_F using ABCD Coefficients

The forward characteristic I_F Vs V_F , on page 6 is represented in two ways;

- the well established V_o and r_s tangent used for rating purposes and (i)
- (ii) a set of constants A, B, C, and D forming the coefficients of the representative equation for V_F in terms of I_F given below:

$$V_F = A + B \cdot \ln(I_F) + C \cdot I_F + D \cdot \sqrt{I_F}$$

The constants, derived by curve fitting software, are given in this report for hot characteristics. The resulting values for V_F agree with the true device characteristic over a current range, which is limited to that plotted.

	25°C Coefficients	125°C Coefficients
А	0.1668812	0.0835139
В	0.3207651	0.2646848
С	6.3917×10 ⁻⁴	6.09992×10 ⁻⁴
D	-0.01267094	3.876887×10 ⁻³

8.0 Frequency Ratings

The curves illustrated in figures 8 to 16 are for guidance only and are superseded by the maximum ratings shown on page 1.

9.0 Square wave ratings

These ratings are given for load component rate of rise of forward current of 100 and 500 A/µs.

10.0 Duty cycle lines

The 100% duty cycle is represented on all the ratings by a straight line. Other duties can be included as parallel to the first.

<u>Curves</u>

10000 M0659LC400-450 Issue 1 25°C 125°C Instantaneous forward current - $I_{\mathsf{FM}}\left(\mathsf{A}\right)$ 1000 100 2 6 1 3 4 5 7 Maximum instantaneous forward voltage - V_{FM} (V)

Figure 1 – Forward characteristics of Limit device

















Figure 6 - Maximum recovery time, t_{rr} (50% chord)



Figure 8 - Sine wave energy per pulse













Figure 12 - Square wave energy per pulse





Figure 13 - Square wave frequency vs. pulse width













Figure 17 – Maximum surge and I²t ratings





Outline Drawing & Ordering Information

